Inelastic X-Ray Scattering

National School on X-Ray and Neutron Scattering Argonne National Laboratory, June 2010

Peter Abbamonte University of Illinois at Urbana-Champaign <u>abbamonte@mrl.uiuc.edu</u> <u>http://users.mrl.uiuc.edu/abbamonte/</u>



Inelastic x-ray scattering – technical

$$H_{0}(t) = \int d\mathbf{x}^{3} \hat{\psi}^{\dagger}(\mathbf{x}, t) \left[\frac{\mathbf{p}^{2}}{2m} + V(\mathbf{x})\right] \hat{\psi}(\mathbf{x}, t) \qquad \mathbf{p} \rightarrow \mathbf{p}_{c} - \frac{e}{c} \mathbf{A} \quad \text{(Lorentz force law)}$$
$$H = H_{0} + H_{1} + H_{2} \qquad \hat{\mathbf{A}}(\mathbf{x}, t) = \sum_{k,\lambda} c \sqrt{\frac{\hbar}{2\omega_{k}}} \left[a_{k,\lambda} \epsilon_{\lambda} e^{i(\mathbf{k} \cdot \mathbf{r} - \omega t)} + a_{k,\lambda}^{\dagger} \epsilon_{\lambda}^{*} e^{-i(\mathbf{k} \cdot \mathbf{r} - \omega t)}\right]$$

$$\begin{split} H_2^I(t) &= -\frac{e^2}{2mc^2} \int d\mathbf{x}^3 \,\hat{\psi}^\dagger(\mathbf{x},t) \,\,\hat{\mathbf{A}}^2(\mathbf{x},t) \,\,\hat{\psi}(\mathbf{x},t) = -\frac{e^2}{mc^2} \int d\mathbf{x}^3 \,\,\hat{\mathbf{A}}^2(\mathbf{x},t) \,\,\hat{n}(\mathbf{x},t) \\ H_1^I(t) &= -\frac{e}{mc} \int d\mathbf{x}^3 \,\hat{\psi}^\dagger(\mathbf{x},t) \,\left[\mathbf{p} \cdot \hat{\mathbf{A}}(\mathbf{x},t) \right] \hat{\psi}(\mathbf{x},t) \\ U_I(\infty,-\infty) &= \exp\left[-i \int_{-\infty}^{\infty} dt \, H^I(t) \,\, e^{-\eta |t|} \right] \end{split}$$

Nonresonant inelastic x-ray scattering

$$w_{f\leftarrow i} = r_0^2 (\epsilon_f^* \cdot \epsilon_i)^2 \sum_{n,m} \left| < n |\hat{n}(\mathbf{k})|m > \right|^2 P_m \,\delta(\omega - \omega_n + \omega_m)$$

Resonant inelastic x-ray scattering (RIXS)

$$w_{f \leftarrow i} = \left| \frac{e^2}{mc^2 \hbar^2} \sum_m \frac{\langle f | \mathbf{p} \cdot \mathbf{A} | m \rangle \langle m | \mathbf{p} \cdot \mathbf{A} | 0 \rangle}{\omega - \omega_m + i\gamma} \right|^2 \delta(\omega - \omega_f + \omega_0)$$

Nonresonant IXS

"Nonresonant" inelastic x-ray scattering

$$w_{f\leftarrow i} = r_0^2 (\epsilon_f^* \cdot \epsilon_i)^2 \sum_{n,m} \left| < n |\hat{n}(\mathbf{k})|m > \right|^2 P_m \,\delta(\omega - \omega_n + \omega_m)$$

$$P_m = \frac{e^{-\hbar\omega_m/kT}}{Z}$$

Dynamic structure factor:

$$S(k,\omega) = \sum_{n,m} \left| \langle n | \hat{n}(\mathbf{k}) | m \rangle \right|^2 P_m \,\delta(\omega - \omega_n + \omega_m)$$

$$\mathbf{k} = \mathbf{k}_f - \mathbf{k}_i \qquad \boldsymbol{\omega} = \boldsymbol{\omega}_f - \boldsymbol{\omega}_i$$

 $S(k,\omega)$ is the Fourier transform of the Van Hove density correlation function:

$$S(\mathbf{k},\omega) = \int d\mathbf{x} dt \ G(\mathbf{x},t) \ e^{-i(\mathbf{k}\cdot\mathbf{x}-\omega\mathbf{t})}$$
$$G(\mathbf{x},t) = \int d\mathbf{x}' dt' < \hat{n}(\mathbf{x},t) \ \hat{n}(\mathbf{x}+\mathbf{x}',t+t') >$$

X-ray "diffraction" actually measures an equal-time correlation function

$$\int S(\mathbf{k},\omega) \, d\omega = G(\mathbf{k},t) \Big|_{t=0} = \int d\mathbf{x} \, G(\mathbf{x},0) \, e^{-i\mathbf{k}\cdot\mathbf{x}}$$

Nonresonant IXS – dynamics!



Excitons

• Band structure

• Plasmons

• Etc.

Resonant IXS (RIXS) – physical picture?

$$w_{f \leftarrow i} = \left| \frac{e^2}{mc^2 \hbar^2} \sum_m \frac{\langle f | \mathbf{p} \cdot \mathbf{A} | m \rangle \langle m | \mathbf{p} \cdot \mathbf{A} | 0 \rangle}{\omega - \omega_m + i\gamma} \right|^2 \delta(\omega - \omega_f + \omega_0)$$



- Coherent two-step process (absorption / emission)
- Denominator can diverge. More *intense*.
- Polarization-dependent; sensitive to symmetry of excitations
- Couples to many types of excitations (magnons?)
- No causality cross section not related to a correlation function. Often hard to decipher.

Comparison to other techniques

Inelastic Neutron Scattering

- Low energy probe ($\omega_i = 25 \text{ meV}$)
- Better energy resolution
- Couples only to nuclei and spins
- Not sensitive to charge excitations (e.g. plasmons)
- Large samples required

Inelastic Electron Scattering

- Can focus beam ~ 1Å
- Decent energy resolution (0.5 eV)
- Sample damage
- Multiple scattering
- Does not work in $H \neq 0$
- Requires UHV

Light (Raman) Scattering

- q=0 probe
- Super high energy resolution (0.1 meV)
- Super high flux (10²² photons/sec on sample)
- Polarization selection rules
- cheap



Advantages / disadvantages of IXS

 \bigcirc

• Direct coupling to charge excitations

• High resolution (<1 meV possible)

- Broad kinematic range
- Small samples OK
- Works in environments (high H, P, etc.)
- No need for high vacuum

- Not sensitive to spin (possible exception from RIXS)
- •Only measures excitations that modulate the electron density
- Longitudinal excitations only (cannot detect TO phonons, transverse plasmons, ...)

Prohibitive flux limitations at high resolution (only phonons practical)

Instrumentation: Overview



Requirements / Challenges

- Cross section small: only 1 in 10⁸ photons are inelastically scattered – high flux needed
- Very high resolving power needed. 2 meV / 20 keV = 10^{-7}
- Must be able to tune energy; both ω_1 and ω_2 for RIXS
- Broad angular acceptance required for enough signal



Instrumentation: Source



Spring-8 (Hyogo, Japan)



ESRF (Grenoble, France)



Advanced Photon Source (Chicago, IL, USA)

Instrumentation: Source



Instrumentation: Sector 30 XOR-IXS Spectrometers



MERIX

- $\Delta E = 10-100 \text{ meV}$
- Electronic excitations:
- plasmons
- excitons
- Mott-gap excitations
- two-magnons



HERIX $\Delta E = < 1 \text{ meV}$ Vibration modes: • acoustic phonons (sound) • optical phonons



Instrumentation: Analyzer





- Need "curved" crystal to accept large $\Delta\Omega$
- Mosaic of ~10⁴ aligned blocks
- Glued on spherical surface
- Used near backscattering
- Slightly tunable by rotating angle



IXS Example 1: Excitons





B. C. Larson, et. al., Phys. Rev. Lett. **99**, 026401 (2007)

IXS Example 2: Plasmons in graphite and graphene





A. H. Castro- Neto, et al., Rev. Mod. Phys. 81, 109 (2008)



IXS Example 2: Plasmons in graphite and graphene (\mathbf{x},t) $\chi(\mathbf{x},\omega) = -\frac{i}{\hbar} \left\langle \left[\hat{n}(\mathbf{x},t), \hat{n}(0,0) \right] \right\rangle \theta(t)$ (0,0)t = 0 ast = 30 ast = 72 as 5 0 0 Υ(Å -5 -5 -5 -5 0 X (Å) X (Å) X (Å) 5 -10 -10 -10 10 -15 15 -15 15 -15 15 t = 200 as t = 516 as t = 1 fs 5 ⁰ Y (Å ⁰ Y (Å[,] -5 -5 -5 -5 -5 0 0 X (Å) X (Å) X (Å) -10 -10 -10 10 10 10 -15 ′ –15 -15 15 15 15 J. P. Reed, et al., submitted

RIXS Example 1: Crystal field excitations in SrCuO₂



A. Higashiya et. al., J. Elect. Spect. Rel. Phen. 144-147, 685 (2005)

RIXS Example 2: Magnons in La₂CuO₄



J. P. Hill, et. al., Phys. Rev. Lett. 100, 097001 (2008)

The Future

- Join mainstream of experimental probes (with STEM, ARPES, etc.)
- Imaging
- Strip detectors (no more analyzers?)
- Surface dynamics [B. Murphy, et. al., Phys. Rev. Lett. 95, 256104 (2005)]
- High pressure (fluctuations near quantum phase transitions)
- ??? New ideas from new people.